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### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	S08
Core Size	8-Bit
Speed	20MHz
Connectivity	I <sup>2</sup> C, LINbus, SPI, UART/USART
Peripherals	LVD, POR, PWM, WDT
Number of I/O	28
Program Memory Size	60KB (60K x 8)
Program Memory Type	FLASH
EEPROM Size	256 x 8
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 12x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	32-LQFP
Supplier Device Package	32-LQFP (7x7)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/nxp-semiconductors/mc9s08pa60vlc">https://www.e-xfl.com/product-detail/nxp-semiconductors/mc9s08pa60vlc</a>

- Input/Output
  - 57 GPIOs including one output-only pin
  - Two 8-bit keyboard interrupt modules (KBI)
  - Two true open-drain output pins
  - Eight, ultra-high current sink pins supporting 20 mA source/sink current
- Package options
  - 64-pin LQFP; 64-pin QFP
  - 48-pin LQFP
  - 44-pin LQFP
  - 32-pin LQFP

# Table of Contents

1	Ordering parts.....	4	5.2.1	Control timing.....	13
1.1	Determining valid orderable parts.....	4	5.2.2	Debug trace timing specifications.....	14
2	Part identification.....	4	5.2.3	FTM module timing.....	15
2.1	Description.....	4	5.3	Thermal specifications.....	16
2.2	Format.....	4	5.3.1	Thermal characteristics.....	16
2.3	Fields.....	4	6	Peripheral operating requirements and behaviors.....	17
2.4	Example.....	5	6.1	External oscillator (XOSC) and ICS characteristics.....	17
3	Parameter Classification.....	5	6.2	NVM specifications.....	19
4	Ratings.....	5	6.3	Analog.....	20
4.1	Thermal handling ratings.....	5	6.3.1	ADC characteristics.....	20
4.2	Moisture handling ratings.....	6	6.3.2	Analog comparator (ACMP) electricals.....	23
4.3	ESD handling ratings.....	6	6.4	Communication interfaces.....	24
4.4	Voltage and current operating ratings.....	6	6.4.1	SPI switching specifications.....	24
5	General.....	7	7	Dimensions.....	27
5.1	Nonswitching electrical specifications.....	7	7.1	Obtaining package dimensions.....	27
5.1.1	DC characteristics.....	7	8	Pinout.....	28
5.1.2	Supply current characteristics.....	12	8.1	Signal multiplexing and pin assignments.....	28
5.1.3	EMC performance.....	13	8.2	Device pin assignment.....	31
5.2	Switching specifications.....	13	9	Revision history.....	34

Field	Description	Values
CC	Package designator	<ul style="list-style-type: none"> <li>• QH = 64-pin QFP</li> <li>• LH = 64-pin LQFP</li> <li>• LF = 48-pin LQFP</li> <li>• LD = 44-pin LQFP</li> <li>• LC = 32-pin LQFP</li> </ul>

## 2.4 Example

This is an example part number:

MC9S08PA60VQH

## 3 Parameter Classification

The electrical parameters shown in this supplement are guaranteed by various methods. To give the customer a better understanding, the following classification is used and the parameters are tagged accordingly in the tables where appropriate:

**Table 1. Parameter Classifications**

P	Those parameters are guaranteed during production testing on each individual device.
C	Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations.
T	Those parameters are achieved by design characterization on a small sample size from typical devices under typical conditions unless otherwise noted. All values shown in the typical column are within this category.
D	Those parameters are derived mainly from simulations.

### NOTE

The classification is shown in the column labeled “C” in the parameter tables where appropriate.

## 4 Ratings

### 4.1 Thermal handling ratings

Symbol	Description	Min.	Max.	Unit	Notes
T <sub>STG</sub>	Storage temperature	-55	150	°C	1
T <sub>SDR</sub>	Solder temperature, lead-free	—	260	°C	2

**Table 2. DC characteristics (continued)**

Symbol	C	Descriptions			Min	Typical <sup>1</sup>	Max	Unit
V <sub>IH</sub>	P	Input high voltage	All digital inputs	V <sub>DD</sub> >4.1V	0.70 × V <sub>DD</sub>	—	—	V
				V <sub>DD</sub> >2.7V	0.85 × V <sub>DD</sub>	—	—	
V <sub>IL</sub>	P	Input low voltage	All digital inputs	V <sub>DD</sub> >4.1V	—	—	0.35 × V <sub>DD</sub>	V
				V <sub>DD</sub> >2.7V	—	—	0.30 × V <sub>DD</sub>	
V <sub>hys</sub>	C	Input hysteresis	All digital inputs	—	0.06 × V <sub>DD</sub>	—	—	mV
I <sub>Iin</sub>	P	Input leakage current	All input only pins (per pin)	V <sub>IN</sub> = V <sub>DD</sub> or V <sub>SS</sub>	—	0.1	1	μA
I <sub>OZ</sub>	P	Hi-Z (off-state) leakage current	All input/output (per pin)	V <sub>IN</sub> = V <sub>DD</sub> or V <sub>SS</sub>	—	0.1	1	μA
I <sub>OZTOT</sub>	C	Total leakage combined for all inputs and Hi-Z pins	All input only and I/O	V <sub>IN</sub> = V <sub>DD</sub> or V <sub>SS</sub>	—	—	2	μA
R <sub>PU</sub>	P	Pullup resistors	All digital inputs, when enabled (all I/O pins other than PTA5/IRQ/TCLK/RESET)	—	17.5	—	52.5	kΩ
R <sub>PU</sub> <sup>3</sup>	P	Pullup resistors	PTA5/IRQ/TCLK/RESET	—	17.5	—	52.5	kΩ
I <sub>IC</sub>	D	DC injection current <sup>4, 5, 6</sup>	Single pin limit	V <sub>IN</sub> < V <sub>SS</sub> , V <sub>IN</sub> > V <sub>DD</sub>	-0.2	—	2	mA
			Total MCU limit, includes sum of all stressed pins		-5	—	25	
C <sub>In</sub>	C	Input capacitance, all pins			—	—	8	pF
V <sub>RAM</sub>	C	RAM retention voltage			—	2.0	—	V

1. Typical values are measured at 25 °C. Characterized, not tested.
2. Only PTB4, PTB5, PTD0, PTD1, PTE0, PTE1, PTH0, and PTH1 support ultra high current output.
3. The specified resistor value is the actual value internal to the device. The pullup value may appear higher when measured externally on the pin.
4. All functional non-supply pins, except for PTA5, are internally clamped to V<sub>SS</sub> and V<sub>DD</sub>.
5. Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the large one.
6. Power supply must maintain regulation within operating V<sub>DD</sub> range during instantaneous and operating maximum current conditions. If the positive injection current (V<sub>in</sub> > V<sub>DD</sub>) is higher than I<sub>DD</sub>, the injection current may flow out of V<sub>DD</sub> and could result in external power supply going out of regulation. Ensure that external V<sub>DD</sub> load will shunt current higher than maximum injection current when the MCU is not consuming power, such as no system clock is present, or clock rate is very low (which would reduce overall power consumption).

**Table 3. LVD and POR Specification**

Symbol	C	Description	Min	Typ	Max	Unit
V <sub>POR</sub>	D	POR re-arm voltage <sup>1</sup>	1.5	1.75	2.0	V
V <sub>LVDH</sub>	C	Falling low-voltage detect threshold - high range (LVDV = 1) <sup>2</sup>	4.2	4.3	4.4	V

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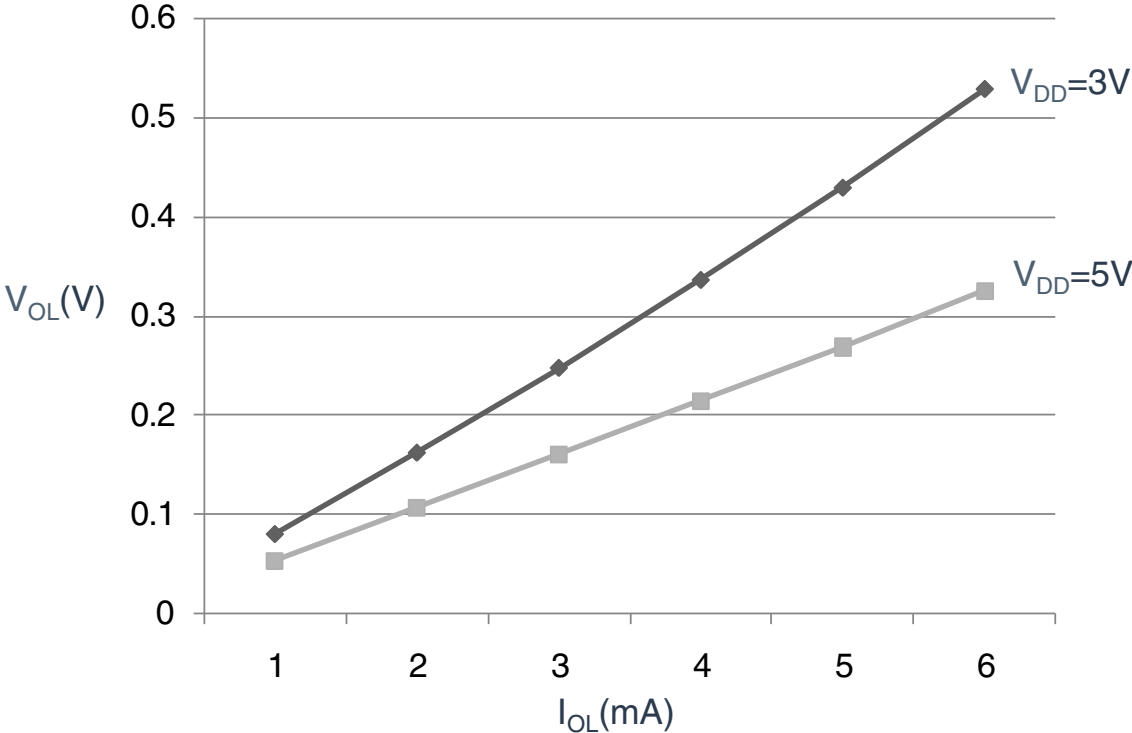


Figure 3. Typical  $I_{OL}$  Vs.  $V_{OL}$

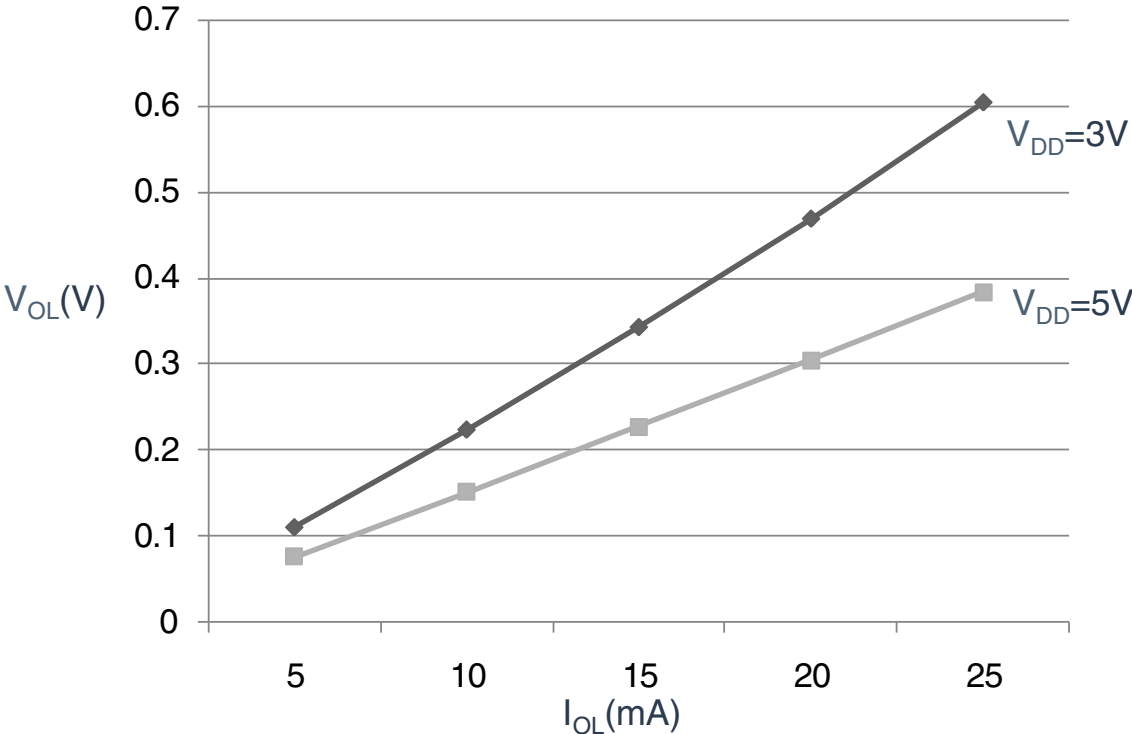


Figure 4. Typical  $I_{OL}$  Vs.  $V_{OL}$  (High current drive)

**Table 4. Supply current characteristics (continued)**

Num	C	Parameter	Symbol	Bus Freq	V <sub>DD</sub> (V)	Typical <sup>1</sup>	Max	Unit	Temp
7	C	ADC adder to stop3	—	—	5	44	—	μA	-40 to 105 °C
	C	ADLPC = 1 ADLSMP = 1 ADCO = 1 MODE = 10B ADICLK = 11B			3	40	—		
8	C	LVD adder to stop3 <sup>4</sup>	—	—	5	130	—	μA	-40 to 105 °C
	C				3	125	—		

1. Data in Typical column was characterized at 5.0 V, 25 °C or is typical recommended value.
2. RTC adder cause <1 μA I<sub>DD</sub> increase typically, RTC clock source is 1 kHz LPO clock.
3. ACMP adder cause <1 μA I<sub>DD</sub> increase typically.
4. LVD is periodically woken up from stop3 by 5% duty cycle. The period is equal to or less than 2 ms.

### 5.1.3 EMC performance

Electromagnetic compatibility (EMC) performance is highly dependant on the environment in which the MCU resides. Board design and layout, circuit topology choices, location and characteristics of external components as well as MCU software operation all play a significant role in EMC performance. The system designer should consult Freescale applications notes such as AN2321, AN1050, AN1263, AN2764, and AN1259 for advice and guidance specifically targeted at optimizing EMC performance.

## 5.2 Switching specifications

### 5.2.1 Control timing

**Table 5. Control timing**

Num	C	Rating	Symbol	Min	Typical <sup>1</sup>	Max	Unit
1	P	Bus frequency ( $t_{cyc} = 1/f_{Bus}$ )	$f_{Bus}$	DC	—	20	MHz
2	P	Internal low power oscillator frequency	$f_{LPO}$	0.67	1.0	1.25	KHz
3	D	External reset pulse width	$t_{extrst}$	1.5 × $t_{Self\_reset}$	—	—	ns
4	D	Reset low drive	$t_{rstdrv}$	34 × $t_{cyc}$	—	—	ns
5	D	BKGD/MS setup time after issuing background debug force reset to enter user or BDM modes	$t_{MSSU}$	500	—	—	ns
6	D	BKGD/MS hold time after issuing background debug force reset to enter user or BDM modes <sup>3</sup>	$t_{MSH}$	100	—	—	ns

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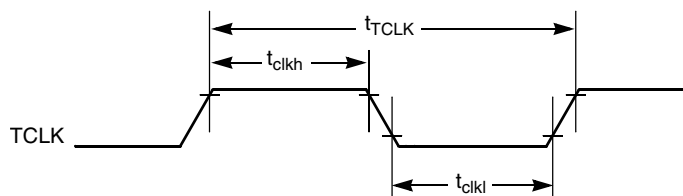


Figure 9. Timer external clock

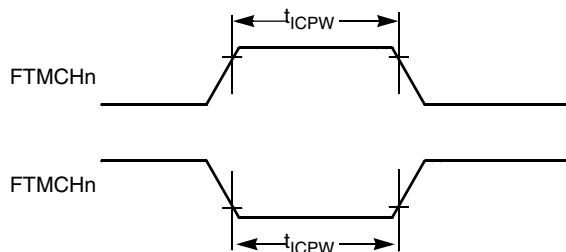


Figure 10. Timer input capture pulse

### 5.3 Thermal specifications

#### 5.3.1 Thermal characteristics

This section provides information about operating temperature range, power dissipation, and package thermal resistance. Power dissipation on I/O pins is usually small compared to the power dissipation in on-chip logic and voltage regulator circuits, and it is user-determined rather than being controlled by the MCU design. To take  $P_{I/O}$  into account in power calculations, determine the difference between actual pin voltage and  $V_{SS}$  or  $V_{DD}$  and multiply by the pin current for each I/O pin. Except in cases of unusually high pin current (heavy loads), the difference between pin voltage and  $V_{SS}$  or  $V_{DD}$  will be very small.

Table 8. Thermal characteristics

Rating	Symbol	Value	Unit
Operating temperature range (packaged)	$T_A$	-40 to 105	$^{\circ}\text{C}$
Junction temperature range	$T_J$	-40 to 150	$^{\circ}\text{C}$
Thermal resistance single-layer board			
64-pin LQFP	$\theta_{JA}$	71	$^{\circ}\text{C}/\text{W}$
64-pin QFP	$\theta_{JA}$	61	$^{\circ}\text{C}/\text{W}$
48-pin LQFP	$\theta_{JA}$	81	$^{\circ}\text{C}/\text{W}$
44-pin LQFP	$\theta_{JA}$	75	$^{\circ}\text{C}/\text{W}$
32-pin LQFP	$\theta_{JA}$	86	$^{\circ}\text{C}/\text{W}$

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## 6.1 External oscillator (XOSC) and ICS characteristics

Table 9. XOSC and ICS specifications (temperature range = -40 to 105 °C ambient)

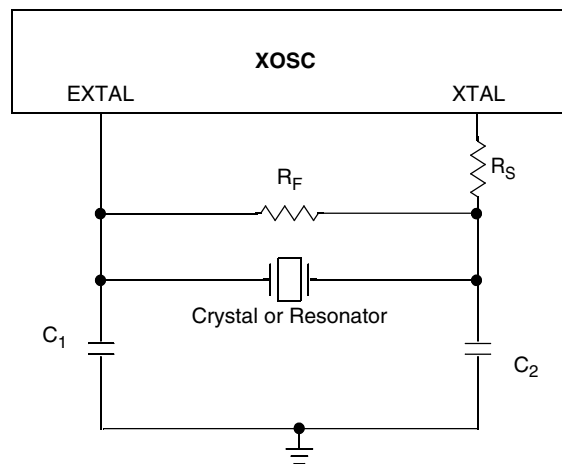
Num	C	Characteristic		Symbol	Min	Typical <sup>1</sup>	Max	Unit
1	C	Oscillator crystal or resonator	Low range (RANGE = 0)	$f_{lo}$	32	—	40	kHz
	C		High range (RANGE = 1) FEE or FBE mode	$f_{hi}$	4	—	20	MHz
	C		High range (RANGE = 1), high gain (HGO = 1), FBELP mode	$f_{hi}$	4	—	20	MHz
	C		High range (RANGE = 1), low power (HGO = 0), FBELP mode	$f_{hi}$	4	—	20	MHz
2	D	Load capacitors		C1, C2	See Note <sup>3</sup>			
3	D	Feedback resistor	Low Frequency, Low-Power Mode	$R_F$	—	—	—	MΩ
			Low Frequency, High-Gain Mode		—	10	—	MΩ
			High Frequency, Low-Power Mode		—	1	—	MΩ
			High Frequency, High-Gain Mode		—	1	—	MΩ
4	D	Series resistor - Low Frequency	Low-Power Mode <sup>4</sup>	$R_S$	—	—	—	kΩ
			High-Gain Mode		—	200	—	kΩ
5	D	Series resistor - High Frequency	Low-Power Mode <sup>4</sup>	$R_S$	—	—	—	kΩ
	D	Series resistor - High Frequency, High-Gain Mode	4 MHz		—	0	—	kΩ
	D		8 MHz		—	0	—	kΩ
	D		16 MHz		—	0	—	kΩ
6	C	Crystal start-up time Low range = 32.768 KHz crystal; High range = 20 MHz crystal, <sup>6</sup>	Low range, low power	$t_{CSTL}$	—	1000	—	ms
	C		Low range, high power		—	800	—	ms
	C		High range, low power	$t_{CSTH}$	—	3	—	ms
	C		High range, high power		—	1.5	—	ms
7	T	Internal reference start-up time		$t_{IRST}$	—	20	50	μs
8	D	Square wave input clock frequency	FEE or FBE mode <sup>2</sup>	$f_{extal}$	0.03125	—	5	MHz
	D		FBELP mode		0	—	20	MHz
9	P	Average internal reference frequency - trimmed		$f_{int\_t}$	—	32.768	—	kHz
10	P	DCO output frequency range - trimmed		$f_{dco\_t}$	16	—	20	MHz
11	P	Total deviation of DCO output from trimmed frequency <sup>5</sup>	Over full voltage and temperature range	$\Delta f_{dco\_t}$	—	—	±2.0	% $f_{dco}$
	C		Over fixed voltage and temperature range of 0 to 70 °C		—	—	±1.0	
12	C	FLL acquisition time <sup>5, 7</sup>		$t_{Acquire}$	—	—	2	ms

Table continues on the next page...

**Table 9. XOSC and ICS specifications (temperature range = -40 to 105 °C ambient)  
(continued)**

Num	C	Characteristic	Symbol	Min	Typical <sup>1</sup>	Max	Unit
13	C	Long term jitter of DCO output clock (averaged over 2 ms interval) <sup>8</sup>	$C_{\text{Jitter}}$	—	0.02	0.2	% $f_{\text{dco}}$

1. Data in Typical column was characterized at 5.0 V, 25 °C or is typical recommended value.
2. When ICS is configured for FEE or FBE mode, input clock source must be divisible using RDIV to within the range of 31.25 kHz to 39.0625 kHz.
3. See crystal or resonator manufacturer's recommendation.
4. Load capacitors ( $C_1, C_2$ ), feedback resistor ( $R_F$ ) and series resistor ( $R_S$ ) are incorporated internally when RANGE = HGO = 0.
5. This parameter is characterized and not tested on each device.
6. Proper PC board layout procedures must be followed to achieve specifications.
7. This specification applies to any time the FLL reference source or reference divider is changed, trim value changed, DMX32 bit is changed, DRS bit is changed, or changing from FLL disabled (FBELP, FBILP) to FLL enabled (FEI, FEE, FBE, FBI). If a crystal/resonator is being used as the reference, this specification assumes it is already running.
8. Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum  $f_{\text{BUS}}$ . Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the FLL circuitry via  $V_{\text{DD}}$  and  $V_{\text{SS}}$  and variation in crystal oscillator frequency increase the  $C_{\text{Jitter}}$  percentage for a given interval.

**Figure 11. Typical crystal or resonator circuit**

## 6.2 NVM specifications

This section provides details about program/erase times and program-erase endurance for the flash and EEPROM memories.

**Table 10. Flash characteristics**

C	Characteristic	Symbol	Min <sup>1</sup>	Typical <sup>2</sup>	Max <sup>3</sup>	Unit <sup>4</sup>
D	Supply voltage for program/erase -40 °C to 105 °C	$V_{\text{prog/erase}}$	2.7	—	5.5	V
D	Supply voltage for read operation	$V_{\text{Read}}$	2.7	—	5.5	V

Table continues on the next page...

**Table 10. Flash characteristics (continued)**

C	Characteristic	Symbol	Min <sup>1</sup>	Typical <sup>2</sup>	Max <sup>3</sup>	Unit <sup>4</sup>
D	NVM Bus frequency	f <sub>NVMBUS</sub>	1	—	25	MHz
D	NVM Operating frequency	f <sub>NVMOP</sub>	0.8	—	1.05	MHz
D	Erase Verify All Blocks	t <sub>VFYALL</sub>	—	—	17030	t <sub>cyc</sub>
D	Erase Verify Flash Block	t <sub>RD1BLK</sub>	—	—	16977	t <sub>cyc</sub>
D	Erase Verify EEPROM Block	t <sub>RD1BLK</sub>	—	—	843	t <sub>cyc</sub>
D	Erase Verify Flash Section	t <sub>RD1SEC</sub>	—	—	517	t <sub>cyc</sub>
D	Erase Verify EEPROM Section	t <sub>DRD1SEC</sub>	0.10	0.10	0.11	ms
D	Read Once	t <sub>RDONCE</sub>	—	—	455	t <sub>cyc</sub>
D	Program Flash (2 word)	t <sub>PGM2</sub>	0.12	0.12	0.14	ms
D	Program Flash (4 word)	t <sub>PGM4</sub>	0.20	0.21	0.24	ms
D	Program Once	t <sub>PGMONCE</sub>	0.20	0.21	0.24	ms
D	Program EEPROM (1 Byte)	t <sub>DPGM1</sub>	0.02	0.02	0.02	ms
D	Program EEPROM (2 Byte)	t <sub>DPGM2</sub>	0.17	0.18	0.20	ms
D	Erase All Blocks	t <sub>ERSALL</sub>	96.01	100.78	125.80	ms
D	Erase Flash Block	t <sub>ERSBLK</sub>	95.98	100.75	125.76	ms
D	Erase Flash Sector	t <sub>ERSPG</sub>	19.10	20.05	25.05	ms
D	Erase EEPROM Sector	t <sub>DERSPG</sub>	4.81	5.05	6.30	ms
D	Unsecure Flash	t <sub>UNSECU</sub>	96.01	100.78	125.80	ms
D	Verify Backdoor Access Key	t <sub>VFYKEY</sub>	—	—	469	t <sub>cyc</sub>
D	Set User Margin Level	t <sub>MLOADU</sub>	—	—	442	t <sub>cyc</sub>
C	FLASH Program/erase endurance T <sub>L</sub> to T <sub>H</sub> = -40 °C to 105 °C	n <sub>FLPE</sub>	10 k	100 k	—	Cycles
C	EEPROM Program/erase endurance TL to TH = -40 °C to 105 °C	n <sub>FLPE</sub>	50 k	500 k	—	Cycles
C	Data retention at an average junction temperature of T <sub>Javg</sub> = 85°C after up to 10,000 program/erase cycles	t <sub>D_ret</sub>	15	100	—	years

1. Minimum times are based on maximum f<sub>NVMOP</sub> and maximum f<sub>NVMBUS</sub>
2. Typical times are based on typical f<sub>NVMOP</sub> and maximum f<sub>NVMBUS</sub>
3. Maximum times are based on minimum f<sub>NVMOP</sub> and maximum f<sub>NVMBUS</sub>
4. t<sub>cyc</sub> = 1 / f<sub>NVMBUS</sub>

Program and erase operations do not require any special power sources other than the normal V<sub>DD</sub> supply. For more detailed information about program/erase operations, see the Memory section.

## 6.3 Analog

## 6.3.2 Analog comparator (ACMP) electricals

**Table 13. Comparator electrical specifications**

C	Characteristic	Symbol	Min	Typical	Max	Unit
D	Supply voltage	$V_{DDA}$	2.7	—	5.5	V
T	Supply current (Operation mode)	$I_{DDA}$	—	10	20	$\mu$ A
D	Analog input voltage	$V_{AIN}$	$V_{SS} - 0.3$	—	$V_{DDA}$	V
P	Analog input offset voltage	$V_{AIO}$	—	—	40	mV
C	Analog comparator hysteresis (HYST=0)	$V_H$	—	15	20	mV
C	Analog comparator hysteresis (HYST=1)	$V_H$	—	20	30	mV
T	Supply current (Off mode)	$I_{DDAOFF}$	—	60	—	nA
C	Propagation Delay	$t_D$	—	0.4	1	$\mu$ s

## 6.4 Communication interfaces

### 6.4.1 SPI switching specifications

The serial peripheral interface (SPI) provides a synchronous serial bus with master and slave operations. Many of the transfer attributes are programmable. The following tables provide timing characteristics for classic SPI timing modes. Refer to the SPI chapter of the chip's reference manual for information about the modified transfer formats used for communicating with slower peripheral devices. All timing is shown with respect to 20%  $V_{DD}$  and 70%  $V_{DD}$ , unless noted, and 100 pF load on all SPI pins. All timing assumes slew rate control is disabled and high drive strength is enabled for SPI output pins.

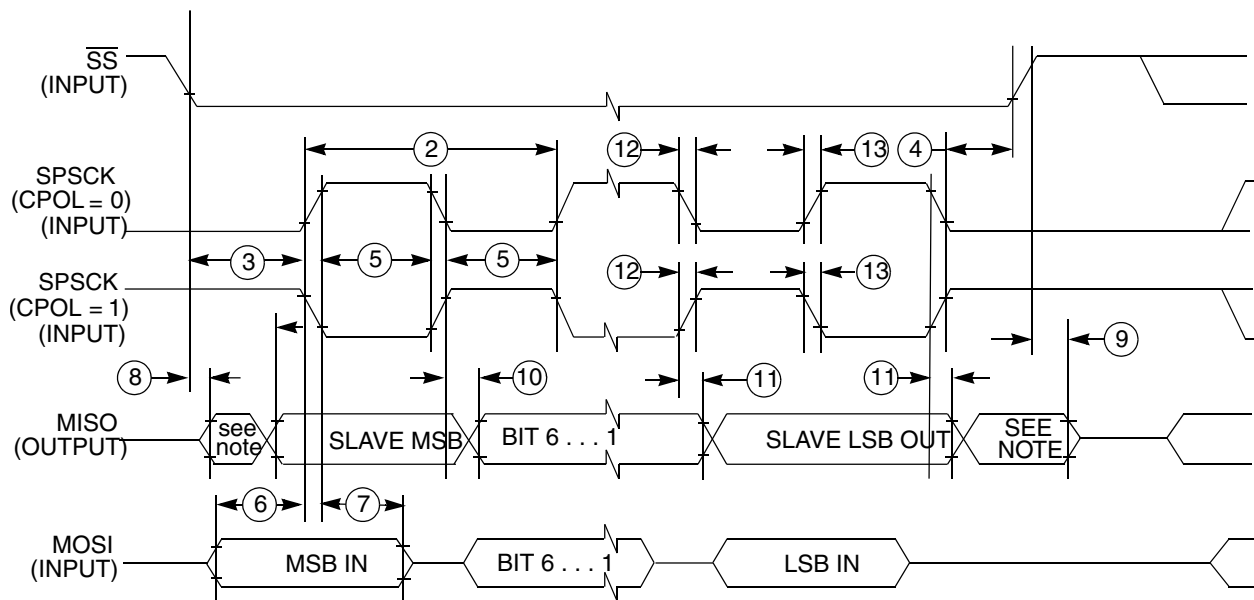
**Table 14. SPI master mode timing**

Nu m.	Symbol	Description	Min.	Max.	Unit	Comment
1	$f_{op}$	Frequency of operation	$f_{Bus}/2048$	$f_{Bus}/2$	Hz	$f_{Bus}$ is the bus clock
2	$t_{SPSCK}$	SPSCK period	$2 \times t_{Bus}$	$2048 \times t_{Bus}$	ns	$t_{Bus} = 1/f_{Bus}$
3	$t_{Lead}$	Enable lead time	1/2	—	$t_{SPSCK}$	—
4	$t_{Lag}$	Enable lag time	1/2	—	$t_{SPSCK}$	—
5	$t_{WSPSCK}$	Clock (SPSCK) high or low time	$t_{Bus} - 30$	$1024 \times t_{Bus}$	ns	—
6	$t_{SU}$	Data setup time (inputs)	15	—	ns	—
7	$t_{HI}$	Data hold time (inputs)	0	—	ns	—
8	$t_v$	Data valid (after SPSCK edge)	—	25	ns	—
9	$t_{HO}$	Data hold time (outputs)	0	—	ns	—

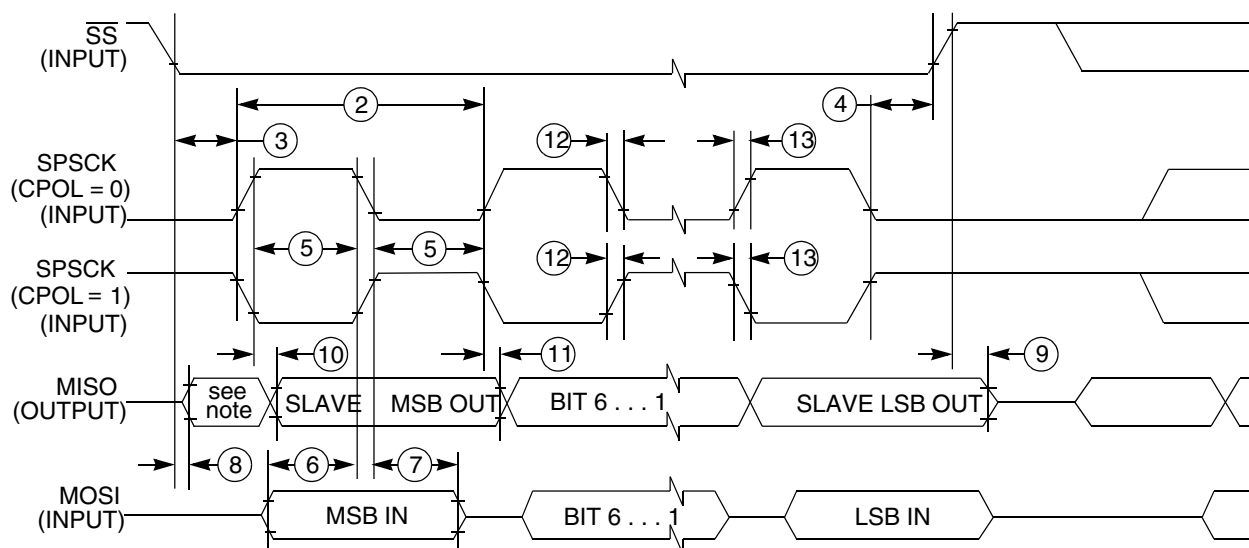
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**Table 15. SPI slave mode timing**

Nu m.	Symbol	Description	Min.	Max.	Unit	Comment
1	$f_{op}$	Frequency of operation	0	$f_{BUS}/4$	Hz	$f_{BUS}$ is the bus clock as defined in .
2	$t_{SPSCK}$	SPSCK period	$4 \times t_{BUS}$	—	ns	$t_{BUS} = 1/f_{BUS}$
3	$t_{Lead}$	Enable lead time	1	—	$t_{BUS}$	—
4	$t_{Lag}$	Enable lag time	1	—	$t_{BUS}$	—
5	$t_{WSPSCK}$	Clock (SPSCK) high or low time	$t_{BUS} - 30$	—	ns	—
6	$t_{SU}$	Data setup time (inputs)	15	—	ns	—
7	$t_{HI}$	Data hold time (inputs)	25	—	ns	—
8	$t_a$	Slave access time	—	$t_{BUS}$	ns	Time to data active from high-impedance state
9	$t_{dis}$	Slave MISO disable time	—	$t_{BUS}$	ns	Hold time to high-impedance state
10	$t_v$	Data valid (after SPSCK edge)	—	25	ns	—
11	$t_{HO}$	Data hold time (outputs)	0	—	ns	—
12	$t_{RI}$	Rise time input	—	$t_{BUS} - 25$	ns	—
	$t_{FI}$	Fall time input				
13	$t_{RO}$	Rise time output	—	25	ns	—
	$t_{FO}$	Fall time output				



**Figure 15. SPI slave mode timing (CPHA = 0)**



NOTE: Not defined!

Figure 16. SPI slave mode timing (CPHA=1)

## 7 Dimensions

### 7.1 Obtaining package dimensions

Package dimensions are provided in package drawings.

To find a package drawing, go to [www.freescale.com](http://www.freescale.com) and perform a keyword search for the drawing's document number:

If you want the drawing for this package	Then use this document number
32-pin LQFP	98ASH70029A
44-pin LQFP	98ASS23225W
48-pin LQFP	98ASH00962A
64-pin QFP	98ASB42844B
64-pin LQFP	98ASS23234W

## 8 Pinout

### 8.1 Signal multiplexing and pin assignments

The following table shows the signals available on each pin and the locations of these pins on the devices supported by this document. The Port Control Module is responsible for selecting which ALT functionality is available on each pin.

**Table 16. Pin availability by package pin-count**

Pin Number				Lowest Priority <-- --> Highest				
64-LQFP 64-QFP	48-LQFP	44-LQFP	32-LQFP	Port Pin	Alt 1	Alt 2	Alt 3	Alt 4
1	1	1	1	PTD1	KBI1P1	FTM2CH3	MOSI1	—
2	2	2	2	PTD0 <sup>1</sup>	KBI1P0	FTM2CH2	SPSCK1	—
3	—	—	—	PTH7	—	—	—	—
4	—	—	—	PTH6	—	—	—	—
5	3	3	—	PTE7	—	TCLK2	—	—
6	4	4	—	PTH2	—	BUSOUT	—	—
7	5	5	3	—	—	—	—	V <sub>DD</sub>
8	6	6	4	—	—	—	V <sub>DDA</sub>	V <sub>REFH</sub>
9	7	7	5	—	—	—	V <sub>SSA</sub>	V <sub>REFL</sub>
10	8	8	6	—	—	—	—	V <sub>SS</sub>
11	9	9	7	PTB7	—	SCL	—	EXTAL
12	10	10	8	PTB6	—	SDA	—	XTAL
13	11	11	—	—	—	—	—	V <sub>SS</sub>
14	—	—	—	PTH1 <sup>1</sup>	—	FTM2CH1	—	—
15	—	—	—	PTH0 <sup>1</sup>	—	FTM2CH0	—	—
16	12	—	—	PTE6	—	—	—	—
17	13	—	—	PTE5	—	—	—	—
18	14	12	9	PTB5 <sup>1</sup>	FTM2CH5	SS0	—	—
19	15	13	10	PTB4 <sup>1</sup>	FTM2CH4	MISO0	—	—
20	16	14	11	PTC3	FTM2CH3	—	ADP11	—
21	17	15	12	PTC2	FTM2CH2	—	ADP10	—
22	18	16	—	PTD7	KBI1P7	TXD2	—	—
23	19	17	—	PTD6	KBI1P6	RXD2	—	—
24	20	18	—	PTD5	KBI1P5	—	—	—
25	21	19	13	PTC1	—	FTM2CH1	ADP9	—
26	22	20	14	PTC0	—	FTM2CH0	ADP8	—
27	—	—	—	PTF7	—	—	ADP15	—

Table continues on the next page...

Table 16. Pin availability by package pin-count (continued)

Pin Number				Lowest Priority <-- --> Highest				
64-LQFP 64-QFP	48-LQFP	44-LQFP	32-LQFP	Port Pin	Alt 1	Alt 2	Alt 3	Alt 4
28	—	—	—	PTF6	—	—	ADP14	—
29	—	—	—	PTF5	—	—	ADP13	—
30	—	—	—	PTF4	—	—	ADP12	—
31	23	21	15	PTB3	KBI0P7	MOSI0	ADP7	—
32	24	22	16	PTB2	KBI0P6	SPSCK0	ADP6	—
33	25	23	17	PTB1	KBI0P5	TXD0	ADP5	—
34	26	24	18	PTB0	KBI0P4	RXD0	ADP4	—
35	—	—	—	PTF3	—	—	—	—
36	—	—	—	PTF2	—	—	—	—
37	27	25	19	PTA7	FTM2FAULT2	—	ADP3	—
38	28	26	20	PTA6	FTM2FAULT1	—	ADP2	—
39	29	—	—	PTE4	—	—	—	—
40	30	27	—	—	—	—	—	V <sub>SS</sub>
41	31	28	—	—	—	—	—	V <sub>DD</sub>
42	—	—	—	PTF1	—	—	—	—
43	—	—	—	PTF0	—	—	—	—
44	32	29	—	PTD4	KBI1P4	—	—	—
45	33	30	21	PTD3	KBI1P3	SS1	—	—
46	34	31	22	PTD2	KBI1P2	MISO1	—	—
47	35	32	23	PTA3	KBI0P3	TXD0	SCL	—
48	36	33	24	PTA2 <sup>2</sup>	KBI0P2	RXD0	SDA	—
49	37	34	25	PTA1	KBI0P1	FTM0CH1	ACMP1	ADP1
50	38	35	26	PTA0	KBI0P0	FTM0CH0	ACMP0	ADP0
51	39	36	27	PTC7	—	TxD1	—	—
52	40	37	28	PTC6	—	RxD1	—	—
53	41	—	—	PTE3	—	SS0	—	—
54	42	38	—	PTE2	—	MISO0	—	—
55	—	—	—	PTG3	—	—	—	—
56	—	—	—	PTG2	—	—	—	—
57	—	—	—	PTG1	—	—	—	—
58	—	—	—	PTG0	—	—	—	—
59	43	39	—	PTE1 <sup>1</sup>	—	MOSI0	—	—
60	44	40	—	PTE0 <sup>1</sup>	—	SPSCK0	TCLK1	—
61	45	41	29	PTC5	—	FTM1CH1	—	—
62	46	42	30	PTC4	—	FTM1CH0	RTCO	—
63	47	43	31	PTA5	IRQ	TCLK0	—	RESET
64	48	44	32	PTA4	—	ACMPO	BKGD	MS



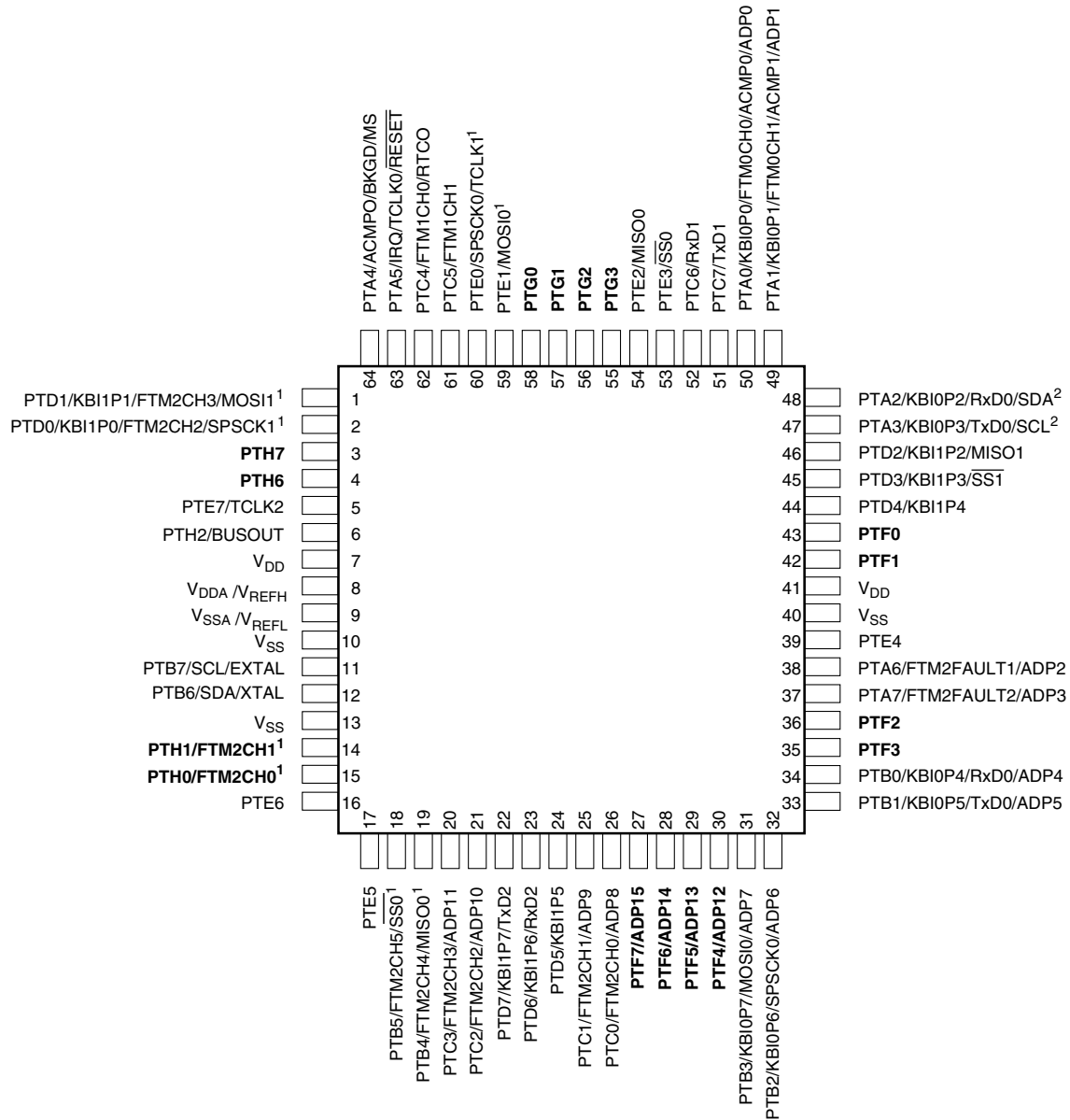
## Pinout

1. This is a high current drive pin when operated as output.
2. This is a true open-drain pin when operated as output.

### Note

When an alternative function is first enabled, it is possible to get a spurious edge to the module. User software must clear any associated flags before interrupts are enabled. The table above illustrates the priority if multiple modules are enabled. The highest priority module will have control over the pin. Selecting a higher priority pin function with a lower priority function already enabled can cause spurious edges to the lower priority module. Disable all modules that share a pin before enabling another module.

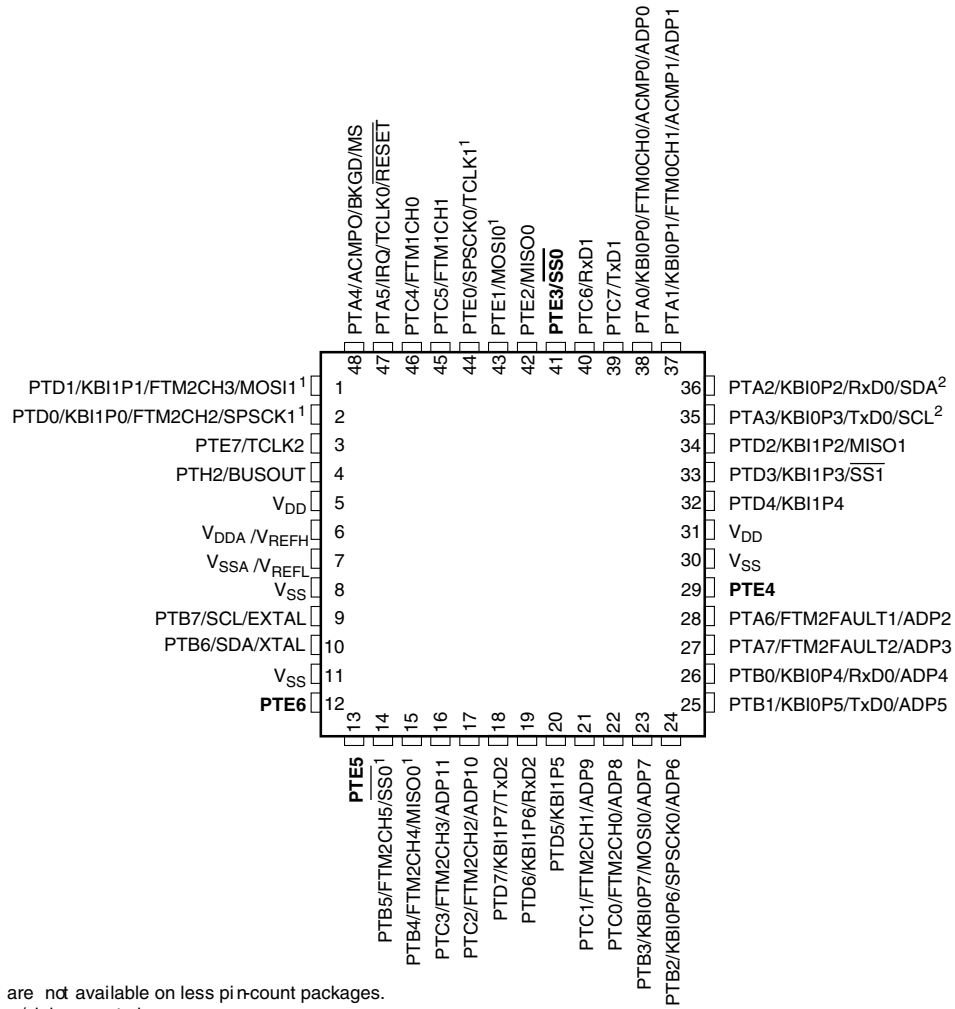
## 8.2 Device pin assignment



Pins in **bold** are not available on less pin-count packages.

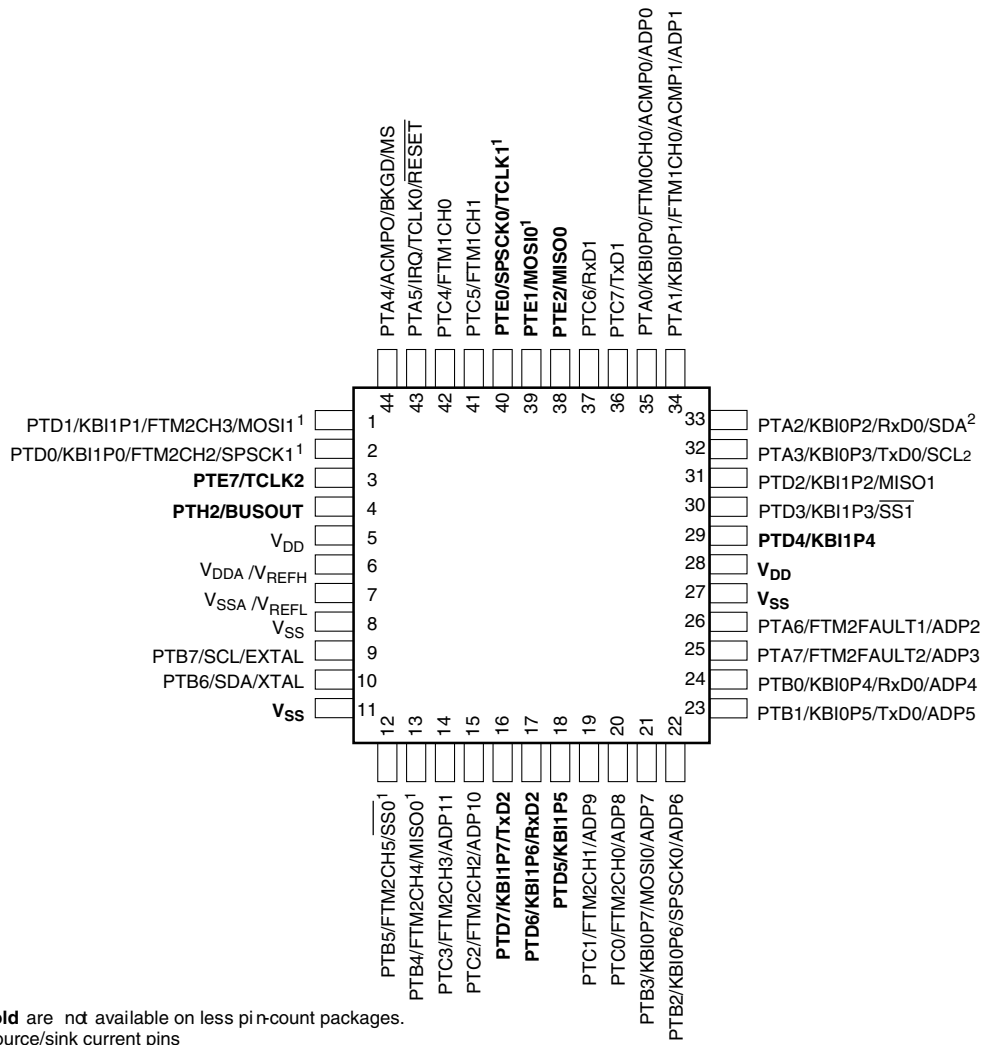
1. High source/sink current pins
2. True open drain pins

**Figure 17. MC9S08PA60 64-pin QFP and LQFP package**



Pins in **bold** are not available on less pin-count packages.  
 1. High source/sink current pins  
 2. True open drain pins

**Figure 18. MC9S08PA60 48-pin LQFP package**



Pins in **bold** are not available on less pin-count packages.  
 1. High source/sink current pins  
 2. True open drain pins

Figure 19. MC9S08PA60 44-pin LQFP package

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